

Search Notes

Application/Control No.

10/630,435

Examiner

Kien T. Nguyen

Applicant(s)/Patent under
Reexamination

KRULL, MARK A.

Art Unit

3714

SEARCHED

Class	Subclass	Date	Examiner
446	1 71 491	7/24/2005	KN
472	137	7/24/2005	KN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR